



100V N-CHANNEL ENHANCEMENT MODE MOSFET

Product Summary

BV _{DSS}	RDS(ON) Max	I _{D Max} T _C = +25°C
100V	$9m\Omega$ @ $V_{GS} = 10V$	84A
	$13m\Omega @ V_{GS} = 4.5V$	70A

Features and Benefits

- 100% Unclamped Inductive Switching (UIS) Test in Production -Ensures More Reliable and Robust End Application
- Low On-Resistance
- Low Input Capacitance
- Lead-Free Finish; RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)

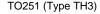
Description and Applications

This MOSFET is designed to minimize the on-state resistance (R_{DS(ON)}) and yet maintain superior switching performance, making it ideal for high-efficiency power management applications.

- Motor Control
- Backlighting

Mechanical Data

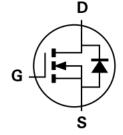
- Case: TO251
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Terminal Connections: See Diagram
- Terminals: Finish Matte Tin Annealed over Copper Leadframe. Solderable per MIL-STD-202, Method 208 @3
- Weight: 0.33 grams (Approximate)











Top View

Bottom View

Top View Pin Configuration

Internal Schematic

Ordering Information (Note 4)

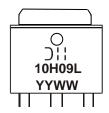
Part Number	Case	Packaging
DMT10H009LH3	TO251 (Type TH3)	75 Pieces / Tube

Notes:

- 1. EU Directive 2002/95/EC (RoHS), 2011/65/EU (RoHS 2) & 2015/863/EU (RoHS 3) compliant. All applicable RoHS exemptions applied.
- 2. See http://www.diodes.com/quality/lead_free/ for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green"
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at https://www.diodes.com/design/support/packaging/diodes-packaging/.

Marking Information

TO251 (Type TH3)



)|| = Manufacturer's Marking 10H09L = Product Type Marking Code YYWW = Date Code Marking YY or YY = Last Two Digits of Year (ex: 19 = 2019) WW or WW = Week (01 to 53)



Maximum Ratings ($@T_A = +25^{\circ}C$, unless otherwise specified.)

Characteristic	Symbol	Value	Unit	
Drain-Source Voltage	V _{DSS}	100	V	
Gate-Source Voltage	V _{GSS}	±20	V	
Continuous Drain Current (Note 5) V _{GS} = 10V	$T_C = +25$ °C $T_C = +70$ °C	I _D	84 67	А
Maximum Body Diode Forward Current (Note 6)	Is	84	А	
Pulsed Drain Current (10µs Pulse, T _C =+25°C, Package Limited)	I _{DM}	336	A	
Pulsed Body Diode Current (10µs Pulse, T _C =+25°C, Package Limited)	I _{SM}	336	Α	
Avalanche Current, L = 0.3mH (Note 9)	I _{AS}	21	Α	
Avalanche Energy, L = 0.3mH (Note 9)	E _{AS}	66	mJ	

Thermal Characteristics (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Value	Unit		
Total Power Dissipation (Note 5)	$T_C = +25^{\circ}C$	P_{D}	96	W	
Total Fower Dissipation (Note 3)	$T_C = +70$ °C	PD	61	VV	
Thermal Resistance, Junction to Ambient (Note 6)	·	R _{0JA}	44	°C/W	
Thermal Resistance, Junction to Case (Note 5)	R _{0JC}	1.3	C/VV		
Operating and Storage Temperature Range		T _{J,} T _{STG}	-55 to +150	°C	

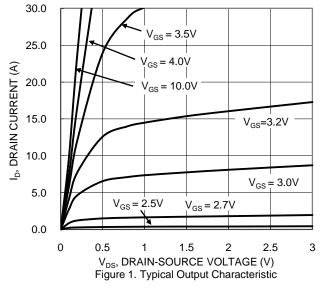
Electrical Characteristics (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 8)							
Drain-Source Breakdown Voltage	BV _{DSS}	100		_	V	$V_{GS} = 0V, I_D = 1mA$	
Zero Gate Voltage Drain Current	I _{DSS}	_	_	1	μA	$V_{DS} = 80V$, $V_{GS} = 0V$	
Gate-Source Leakage	I _{GSS}	_	_	100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$	
ON CHARACTERISTICS (Note 8)							
Gate Threshold Voltage	V _{GS(TH)}	1.3	_	2.5	V	$V_{DS} = V_{GS}$, $I_D = 250\mu A$	
Static Drain-Source On-Resistance	D	_	7	9	mΩ	$V_{GS} = 10V, I_D = 20A$	
Static Dialii-Source Off-Resistance	R _{DS(ON)}	_	9	13	mΩ	$V_{GS} = 4.5V, I_D = 5A$	
Diode Forward Voltage	V_{SD}		8.0	1.2	V	$V_{GS} = 0V, I_{S} = 20A$	
DYNAMIC CHARACTERISTICS (Note 7)							
Input Capacitance	Ciss	_	2309	_		V _{DS} = 50V, V _{GS} = 0V f = 1MHz	
Output Capacitance	Coss	_	536	_	pF		
Reverse Transfer Capacitance	Crss	_	13.7	_			
Gate Resistance	R_g	-	1.9	_	Ω	$V_{DS} = 0V$, $V_{GS} = 0V$, $f = 1MHz$	
Total Gate Charge	Q_g	_	20.2	_		V 50V I 00A	
Gate-Source Charge	Q_{gs}	_	7.0	_	nC	$V_{DD} = 50V, I_D = 20A,$ $V_{GS} = 4.5V$	
Gate-Drain Charge	Q_{gd}	-	8.5	_		VGS = 4.5V	
Turn-On Delay Time	t _{D(ON)}	_	5.4	_			
Turn-On Rise Time	t _R	_	10.6	_	ns	$V_{DD} = 50V, V_{GS} = 10V,$ $I_{D} = 20A, R_{g} = 3\Omega$	
Turn-Off Delay Time	t _{D(OFF)}	-	28.3	_	115		
Turn-Off Fall Time	t _F	_	14.9	_			
Reverse Recovery Time	t _{RR}	_	44.3	_	ns	I 20.4 di/dt _ 100.4/up	
Reverse Recovery Charge	Q _{RR}		65.5	_	nC	I _F = 20A, di/dt = 100A/μs	

Notes:

- 5. Device mounted on infinite heatsink.6. Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate.
- Guaranteed by design. Not subject to production testing.
 Short duration pulse test used to minimize self-heating effect.
- 9. I_{AS} and E_{AS} ratings are based on low frequency and duty cycles to keep T_J = +25°C.





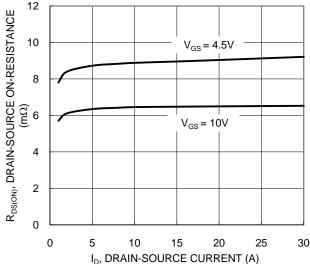


Figure 3. Typical On-Resistance vs. Drain Current

and Gate Voltage

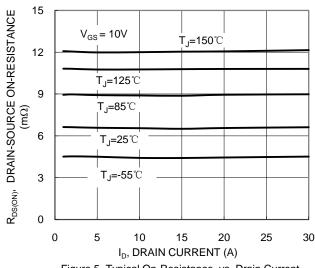


Figure 5. Typical On-Resistance vs. Drain Current and Junction Temperature

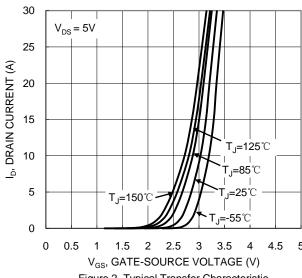


Figure 2. Typical Transfer Characteristic

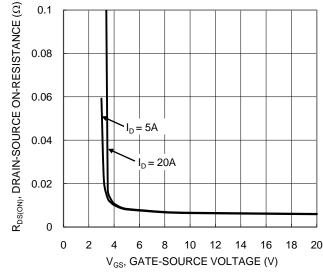


Figure 4. Typical Transfer Characteristic

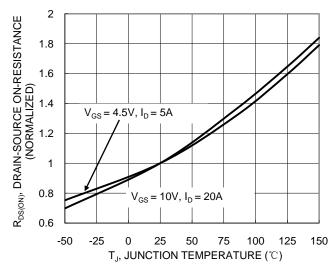
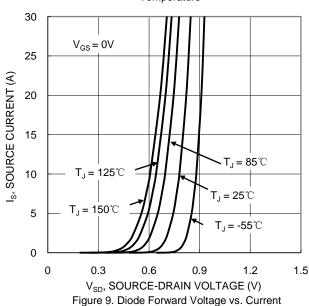


Figure 6. On-Resistance Variation with Junction Temperature



0.02 R_{DS(ON)}, DRAIN-SOURCE ON-RESISTANCE 0.016 $V_{GS} = 4.5V, I_{D} = 5A$ 0.012 0.008 $V_{GS} = 10V, I_{D} = 20A$ 0.004 0 -25 0 -50 25 50 75 100 125 150 T_J, JUNCTION TEMPERATURE (°C)

Figure 7. On-Resistance Variation with Junction
Temperature



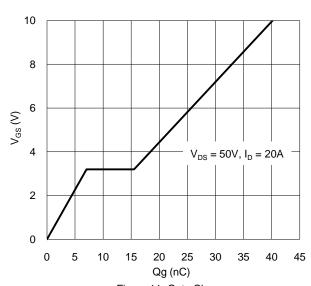


Figure 11. Gate Charge

DMT10H009LH3

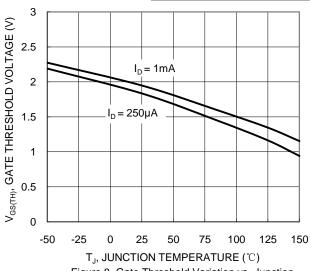
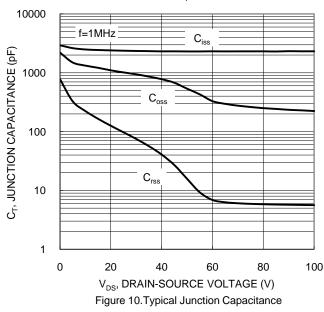
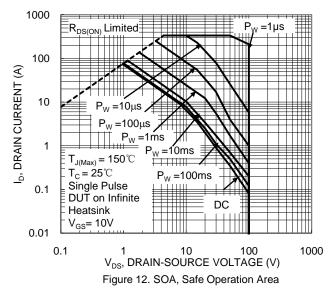


Figure 8. Gate Threshold Variation vs. Junction Temperature







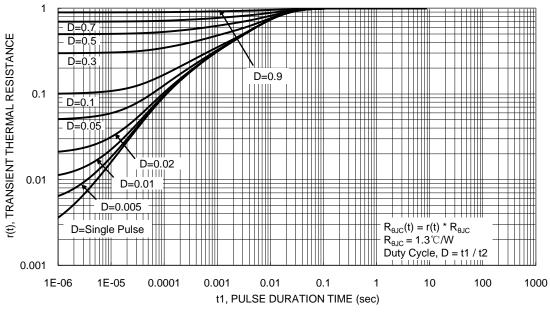
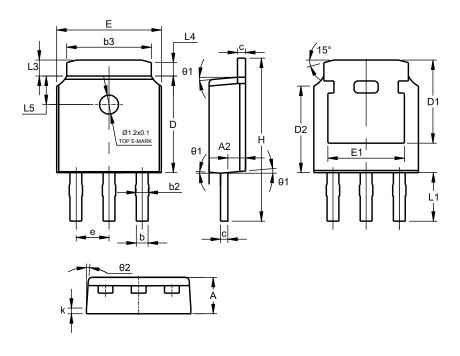


Figure 13. Transient Thermal Resistance

Package Outline Dimensions

Please see http://www.diodes.com/package-outlines.html for the latest version.

TO251 (Type TH3)



TO251						
(Type TH3)						
Dim	Min	Тур				
Α	2.20	2.40	2.30			
A2	0.97	1.17	1.07			
b	0.68	0.90	0.78			
b2	0.76	0.95	0.84			
b3	5.20	5.50	5.33			
C	0.43	0.63	0.53			
D	5.98	6.22	6.10			
D1	5.30 REF					
D2	5.26	5.46				
е	2.	286 BS	C			
Е	6.40	6.80	6.60			
E1	4.63	5.03	4.83			
Н	9.40	9.85	9.62			
k	0.40REF					
L1	2.30	2.70	2.50			
L3	0.88 1.28		1.02			
L4	0.75 REF					
L5	1.65	1.95	1.80			
θ1	5°	9°	7°			
θ2	5°	9°	7°			
All Dimensions in mm						



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